
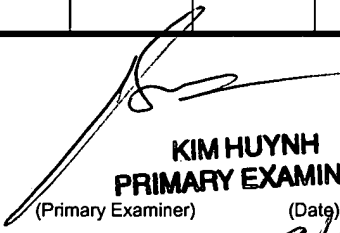



Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/592,009	LEE ET AL.	
	Examiner	Art Unit	
	Kim Huynh	2182	

ISSUE CLASSIFICATION											
ORIGINAL					CROSS REFERENCE(S)						
CLASS	SUBCLASS				CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
710	19				710	15					
INTERNATIONAL CLASSIFICATION					712	228					
G	0	6	F	3/00							
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----- (Assistant Examiner) (Date)					 KIM HUYNH PRIMARY EXAMINER (Primary Examiner) (Date) 2/14/05					Total Claims Allowed: 13	
 (Legal Instruments Examiner) (Date)										O.G. Print Claim(s) 1	O.G. Print Fig. 7

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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